

Search Notes

Application/Control No.

10/734,245

Examiner

Christopher P. Schwartz

Applicant(s)/Patent under
Reexamination

NIHEI ET AL.

Art Unit

3683

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Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Updated-- see EAST text search attached	8/6/2005	CPS